# **Balanced Modulators/ Demodulators**

These devices were designed for use where the output voltage is a product of an input voltage (signal) and a switching function (carrier). Typical applications include suppressed carrier and amplitude modulation, synchronous detection, FM detection, phase detection, and chopper applications. See ON Semiconductor Application Note AN531 for additional design information.

#### Features

- Excellent Carrier Suppression -65 dB typ @ 0.5 MHz
  - -50 dB typ @ 10 MHz
- Adjustable Gain and Signal Handling
- Balanced Inputs and Outputs
- High Common Mode Rejection -85 dB Typical
- This Device Contains 8 Active Transistors
- Pb-Free Package is Available\*



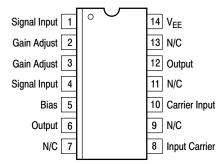
http://onsemi.com





PDIP-14 P SUFFIX CASE 646

## **PIN CONNECTIONS**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 12 of this data sheet.

#### **DEVICE MARKING INFORMATION**

See general marking information in the device marking section on page 12 of this data sheet.

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

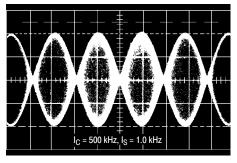


Figure 1. Suppressed Carrier Output Waveform

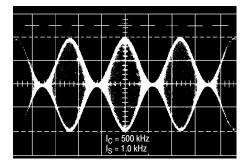


Figure 3. Amplitude Modulation Output Waveform

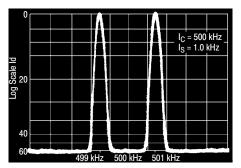


Figure 2. Suppressed Carrier Spectrum

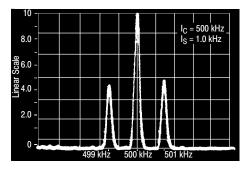


Figure 4. Amplitude–Modulation Spectrum

Rating	Symbol	Value	Unit
Applied Voltage (V6-V8, V10-V1, V12-V8, V12-V10, V8-V4, V8-V1, V10-V4, V6-V10, V2-V5, V3-V5)	ΔV	30	Vdc
Differential Input Signal	V8 – V10 V4 – V1	+5.0 ±(5+I5R <sub>e</sub> )	Vdc
Maximum Bias Current	I <sub>5</sub>	10	mA
Thermal Resistance, Junction-to-Air Plastic Dual In-Line Package	$R_{ hetaJA}$	100	°C/W
Operating Ambient Temperature Range MC1496 MC1496B	T <sub>A</sub>	0 to +70 -40 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Electrostatic Discharge Sensitivity (ESD) Human Body Model (HBM) Machine Model (MM)	ESD	2000 400	V

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

<b>ELECTRICAL CHARACTERISTICS</b> (V <sub>CC</sub> = 12 Vdc, V <sub>EE</sub> = -8.0 Vdc, I5 = 1.0 mAdc, R <sub>L</sub> = 3.9 kΩ, R <sub>e</sub> = 1.0 kΩ, T <sub>A</sub> = T <sub>low</sub> to T <sub>high</sub> ,
all input and output characteristics are single-ended, unless otherwise noted.) (Note 1)

Characteristic	Fig.	Note	Symbol	Min	Тур	Max	Unit
$ \begin{array}{ll} \mbox{Carrier Feedthrough} & f_{C} = 60 \mbox{ mVrms sine wave and } & f_{C} = 1.0 \mbox{ kHz} & f_{C} = 10 \mbox{ MHz} & f_{C} = 300 \mbox{ mVpp square wave: } & f_{C} = 300 \mbox{ mVpp square wave: } & f_{C} = 1.0 \mbox{ kHz} & f_{C} = 1.0 \$	5	1	V <sub>CFT</sub>	- - -	40 140 0.04 20	- - 0.4 200	μVrms mVrms
	5	2	Ma a	_	20	200	dB
$\begin{array}{l} \text{Carrier Suppression} \\ f_S = 10 \text{ kHz}, 300 \text{ mVrms} \\ f_C = 500 \text{ kHz}, 60 \text{ mVrms sine wave} \\ f_C = 10 \text{ MHz}, 60 \text{ mVrms sine wave} \end{array}$	5	2	V <sub>CS</sub>	40 -	65 50		ив k
Transadmittance Bandwidth (Magnitude) ( $R_L = 50 \Omega$ ) Carrier Input Port, $V_C = 60 mVrms$ sine wave $f_S = 1.0 kHz$ , 300 mVrms sine wave Signal Input Port, $V_S = 300 mVrms$ sine wave		8	BW <sub>3dB</sub>	-	300 80	-	MHz
$ V_{C}  = 0.5 \text{ Vdc}$ Signal Gain (V <sub>S</sub> = 100 mVrms, f = 1.0 kHz;  V <sub>C</sub>  = 0.5 Vdc)	10	3	A <sub>VS</sub>	2.5	3.5	_	V/V
Single-Ended Input Impedance, Signal Port, f = 5.0 MHz Parallel Input Resistance Parallel Input Capacitance		_	r <sub>ip</sub> C <sub>ip</sub>		200 2.0		kΩ pF
Single-Ended Output Impedance, f = 10 MHz Parallel Output Resistance Parallel Output Capacitance	6	-	r <sub>op</sub> c <sub>oo</sub>		40 5.0		kΩ pF
Input Bias Current I <sub>bS</sub> = $\frac{11 + 14}{2}$ ; I <sub>bC</sub> = $\frac{18 + 110}{2}$	7	-	I <sub>bS</sub> I <sub>bC</sub>		12 12	30 30	μΑ
Input Offset Current $I_{ioS} = I1-I4$ ; $I_{ioC} = I8-I10$		-	∣I <sub>ioS</sub> ∣ I <sub>ioC</sub> ∣	- -	0.7 0.7	7.0 7.0	μΑ
Average Temperature Coefficient of Input Offset Current $(T_A = -55^{\circ}C \text{ to } +125^{\circ}C)$	7	-	TC <sub>lio</sub>	-	2.0	-	nA/°C
Output Offset Current (I6–I9)	7	-	I <sub>oo</sub>	-	14	80	μA
Average Temperature Coefficient of Output Offset Current $(T_A = -55^{\circ}C \text{ to } +125^{\circ}C)$		-	TC <sub>loo</sub>	-	90	-	nA/°C
Common–Mode Input Swing, Signal Port, $f_S = 1.0 \text{ kHz}$		4	CMV	-	5.0	-	Vpp
Common–Mode Gain, Signal Port, $f_S = 1.0 \text{ kHz}$ , $ V_C  = 0.5 \text{ Vdc}$		-	ACM	-	-85	-	dB
Common–Mode Quiescent Output Voltage (Pin 6 or Pin 9)		-	V <sub>out</sub>	-	8.0	-	Vpp
Differential Output Voltage Swing Capability		-	V <sub>out</sub>	-	8.0	-	Vpp
Power Supply Current 16 +112 114		6	I <sub>CC</sub> I <sub>EE</sub>	-	2.0 3.0	4.0 5.0	mAdo
DC Power Dissipation	7	5	PD	-	33	-	mW

1.  $T_{low} = 0^{\circ}C$  for MC1496 = -40°C for MC1496B  $T_{high} = +70^{\circ}C$  for MC1496 = +125°C for MC1496B

## **GENERAL OPERATING INFORMATION**

#### **Carrier Feedthrough**

Carrier feedthrough is defined as the output voltage at carrier frequency with only the carrier applied (signal voltage = 0).

Carrier null is achieved by balancing the currents in the differential amplifier by means of a bias trim potentiometer (R1 of Figure 5).

## **Carrier Suppression**

Carrier suppression is defined as the ratio of each sideband output to carrier output for the carrier and signal voltage levels specified.

Carrier suppression is very dependent on carrier input level, as shown in Figure 22. A low value of the carrier does not fully switch the upper switching devices, and results in lower signal gain, hence lower carrier suppression. A higher than optimum carrier level results in unnecessary device and circuit carrier feedthrough, which again degenerates the suppression figure. The MC1496 has been characterized with a 60 mVrms sinewave carrier input signal. This level provides optimum carrier suppression at carrier frequencies in the vicinity of 500 kHz, and is generally recommended for balanced modulator applications.

Carrier feedthrough is independent of signal level,  $V_S$ . Thus carrier suppression can be maximized by operating with large signal levels. However, a linear operating mode must be maintained in the signal–input transistor pair – or harmonics of the modulating signal will be generated and appear in the device output as spurious sidebands of the suppressed carrier. This requirement places an upper limit on input–signal amplitude (see Figure 20). Note also that an optimum carrier level is recommended in Figure 22 for good carrier suppression and minimum spurious sideband generation.

At higher frequencies circuit layout is very important in order to minimize carrier feedthrough. Shielding may be necessary in order to prevent capacitive coupling between the carrier input leads and the output leads.

## Signal Gain and Maximum Input Level

Signal gain (single–ended) at low frequencies is defined as the voltage gain,

$$A_{VS} = \frac{V_0}{V_S} = \frac{R_L}{R_e + 2r_e} \text{ where } r_e = \frac{26 \text{ mV}}{\text{I5(mA)}}$$

A constant dc potential is applied to the carrier input terminals to fully switch two of the upper transistors "on" and two transistors "off" ( $V_C = 0.5$  Vdc). This in effect forms a cascode differential amplifier.

Linear operation requires that the signal input be below a critical value determined by  $R_E$  and the bias current I5.

$$V_{\rm S} \leq 15 R_{\rm E}$$
 (Volts peak)

Note that in the test circuit of Figure 10,  $V_S$  corresponds to a maximum value of 1.0 V peak.

#### **Common Mode Swing**

The common-mode swing is the voltage which may be applied to both bases of the signal differential amplifier, without saturating the current sources or without saturating the differential amplifier itself by swinging it into the upper switching devices. This swing is variable depending on the particular circuit and biasing conditions chosen.

#### **Power Dissipation**

Power dissipation,  $P_D$ , within the integrated circuit package should be calculated as the summation of the voltage-current products at each port, i.e. assuming V12 = V6, I5 = I6 = I12 and ignoring base current,  $P_D$ =2 I5 (V6 - V14) + I5)V5 - V14 where subscripts refer to pin numbers.

#### **Design Equations**

The following is a partial list of design equations needed to operate the circuit with other supply voltages and input conditions.

A. Operating Current

The internal bias currents are set by the conditions at Pin 5. Assume:

$$\begin{split} I5 &= I6 = I12, \\ I_B &< < I_C \text{ for all transistors} \end{split}$$

then :

$$R5 = \frac{V - -\varphi}{I5} - 500 \ \Omega$$
 where: R5 is the resistor between  
Pin 5 and ground  
 $\varphi = 0.75 \text{ at } T_A = +25^{\circ}C$ 

The MC1496 has been characterized for the condition  $I_5 = 1.0$  mA and is the generally recommended value.

B. Common-Mode Quiescent Output Voltage

#### Biasing

The MC1496 requires three dc bias voltage levels which must be set externally. Guidelines for setting up these three levels include maintaining at least 2.0 V collector-base bias on all transistors while not exceeding the voltages given in the absolute maximum rating table;

$$30 \text{ Vdc} \ge [(V6, V12) - (V8, V10)] \ge 2 \text{ Vdc}$$
  

$$30 \text{ Vdc} \ge [(V8, V10) - (V1, V4)] \ge 2.7 \text{ Vdc}$$
  

$$30 \text{ Vdc} \ge [(V1, V4) - (V5)] \ge 2.7 \text{ Vdc}$$

The foregoing conditions are based on the following approximations:

Bias currents flowing into Pins 1, 4, 8 and 10 are transistor base currents and can normally be neglected if external bias dividers are designed to carry 1.0 mA or more.

#### **Transadmittance Bandwidth**

Carrier transadmittance bandwidth is the 3.0 dB bandwidth of the device forward transadmittance as defined by:

$$\gamma_{21C} = \frac{i_0 \text{ (each sideband)}}{v_s \text{ (signal)}} \quad V_0 = 0$$

Signal transadmittance bandwidth is the 3.0 dB bandwidth of the device forward transadmittance as defined by:

$$\gamma_{21S} = \frac{i_0 \text{ (signal)}}{v_s \text{ (signal)}} | V_c = 0.5 \text{ Vdc}, V_0 = 0$$

#### **Coupling and Bypass Capacitors**

Capacitors C1 and C2 (Figure 5) should be selected for a reactance of less than 5.0  $\Omega$  at the carrier frequency.

#### **Output Signal**

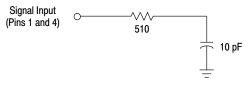
The output signal is taken from Pins 6 and 12 either balanced or single-ended. Figure 11 shows the output levels of each of the two output sidebands resulting from variations in both the carrier and modulating signal inputs with a single-ended output connection.

#### **Negative Supply**

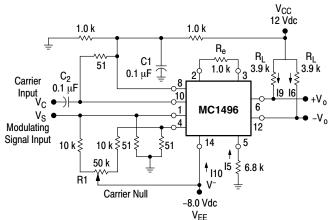
V<sub>EE</sub> should be dc only. The insertion of an RF choke in series with V<sub>EE</sub> can enhance the stability of the internal current sources.

#### Signal Port Stability

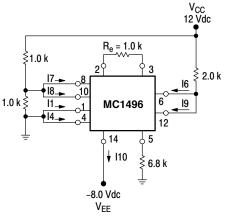
Under certain values of driving source impedance, oscillation may occur. In this event, an RC suppression network should be connected directly to each input using short leads. This will reduce the Q of the source-tuned circuits that cause the oscillation.



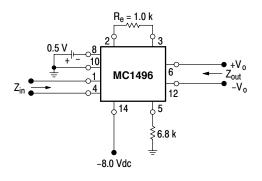
An alternate method for low-frequency applications is to insert a 1.0 k $\Omega$  resistor in series with the input (Pins 1, 4). In this case input current drift may cause serious degradation of carrier suppression.











NOTE: Shielding of input and output leads may be needed to properly perform these tests.

#### Figure 6. Input–Output Impedance

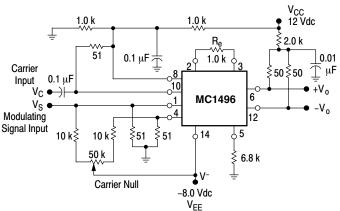


Figure 8. Transconductance Bandwidth

# **TEST CIRCUITS**

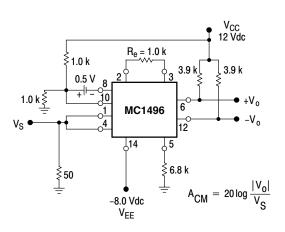
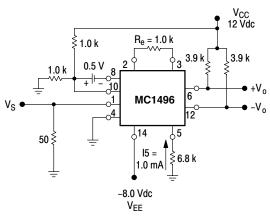
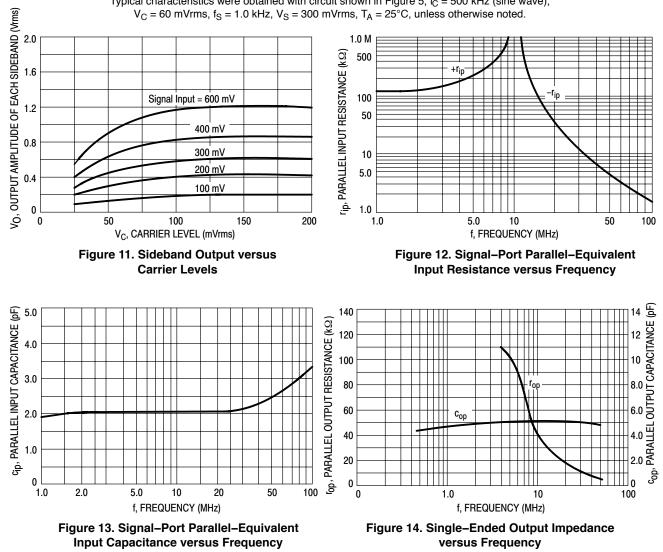


Figure 9. Common Mode Gain





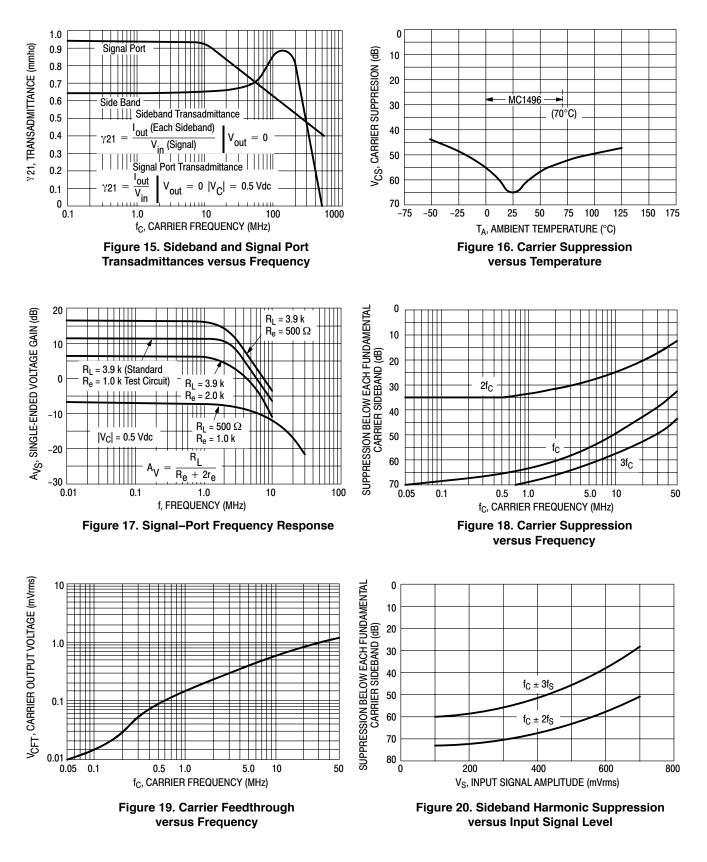
# **TYPICAL CHARACTERISTICS**

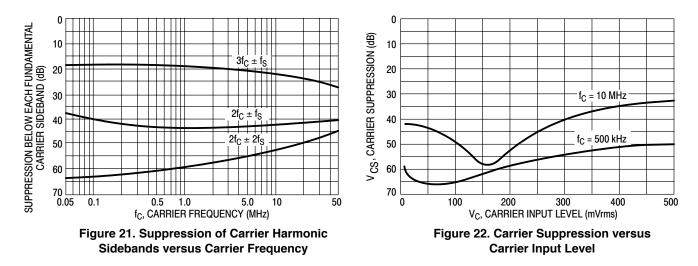


Typical characteristics were obtained with circuit shown in Figure 5,  $f_{\rm C}$  = 500 kHz (sine wave),

## TYPICAL CHARACTERISTICS (continued)

Typical characteristics were obtained with circuit shown in Figure 5, f<sub>C</sub> = 500 kHz (sine wave),  $V_C = 60 \text{ mVrms}$ , f<sub>S</sub> = 1.0 kHz,  $V_S = 300 \text{ mVrms}$ , T<sub>A</sub> = 25°C, unless otherwise noted.





#### **OPERATIONS INFORMATION**

The MC1496, a monolithic balanced modulator circuit, is shown in Figure 23.

This circuit consists of an upper quad differential amplifier driven by a standard differential amplifier with dual current sources. The output collectors are cross–coupled so that full–wave balanced multiplication of the two input voltages occurs. That is, the output signal is a constant times the product of the two input signals.

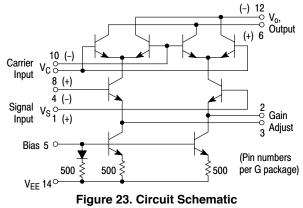
Mathematical analysis of linear ac signal multiplication indicates that the output spectrum will consist of only the sum and difference of the two input frequencies. Thus, the device may be used as a balanced modulator, doubly balanced mixer, product detector, frequency doubler, and other applications requiring these particular output signal characteristics.

The lower differential amplifier has its emitters connected to the package pins so that an external emitter resistance may be used. Also, external load resistors are employed at the device output.

#### Signal Levels

The upper quad differential amplifier may be operated either in a linear or a saturated mode. The lower differential amplifier is operated in a linear mode for most applications.

For low-level operation at both input ports, the output signal will contain sum and difference frequency



components and have an amplitude which is a function of the product of the input signal amplitudes.

For high–level operation at the carrier input port and linear operation at the modulating signal port, the output signal will contain sum and difference frequency components of the modulating signal frequency and the fundamental and odd harmonics of the carrier frequency. The output amplitude will be a constant times the modulating signal amplitude. Any amplitude variations in the carrier signal will not appear in the output.

The linear signal handling capabilities of a differential amplifier are well defined. With no emitter degeneration, the maximum input voltage for linear operation is approximately 25 mV peak. Since the upper differential amplifier has its emitters internally connected, this voltage applies to the carrier input port for all conditions.

Since the lower differential amplifier has provisions for an external emitter resistance, its linear signal handling range may be adjusted by the user. The maximum input voltage for linear operation may be approximated from the following expression:

#### $V = (I5) (R_E)$ volts peak.

This expression may be used to compute the minimum value of  $R_E$  for a given input voltage amplitude.

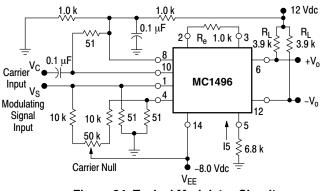


Figure 24. Typical Modulator Circuit

Carrier Input Signal (V <sub>C</sub> )	Approximate Voltage Gain	Output Signal Frequency(s)	
Low-level dc	$\frac{R_{L}V_{C}}{2(R_{E}+2r_{e})\left(\frac{KT}{q}\right)}$	f <sub>M</sub>	
High-level dc	$\frac{R_{L}}{R_{E}+2r_{e}}$	f <sub>M</sub>	
Low-level ac	$\frac{R_{L} V_{C}(rms)}{2\sqrt{2}  \left(\frac{K T}{q}\right) (R_{E} + 2r_{e})}$	$f_C \pm f_M$	
High–level ac	$\frac{0.637 \text{ R}_{\text{L}}}{\text{R}_{\text{F}} + 2\text{r}_{\text{e}}}$	$f_C \pm f_M, 3f_C \pm f_M, 5f_C \pm f_M, \ldots$	

#### Table 1. Voltage Gain and Output Frequencies

2. Low-level Modulating Signal,  $V_M$ , assumed in all cases.  $V_C$  is Carrier Input Voltage.

3. When the output signal contains multiple frequencies, the gain expression given is for the output amplitude ofeach of the two desired outputs,  $f_{C} + f_{M}$  and  $f_{C} - f_{M}$ .

4. All gain expressions are for a single-ended output. For a differential output connection, multiply each expression by two.

5.  $R_1 = Load$  resistance.

6.  $R_E^{L}$  = Emitter resistance between Pins 2 and 3.

7. re = Transistor dynamic emitter resistance, at 25°C; 26 mV

$$re \approx \frac{1}{I_5 (mA)}$$

8. K = Boltzmann's Constant, T = temperature in degrees Kelvin, q = the charge on an electron.

The gain from the modulating signal input port to the output is the MC1496 gain parameter which is most often of interest to the designer. This gain has significance only when the lower differential amplifier is operated in a linear mode, but this includes most applications of the device.

As previously mentioned, the upper quad differential amplifier may be operated either in a linear or a saturated mode. Approximate gain expressions have been developed for the MC1496 for a low–level modulating signal input and the following carrier input conditions:

- 1) Low-level dc
- 2) High-level dc
- 3) Low-level ac
- 4) High-level ac

These gains are summarized in Table 1, along with the frequency components contained in the output signal.

#### **APPLICATIONS INFORMATION**

Double sideband suppressed carrier modulation is the basic application of the MC1496. The suggested circuit for this application is shown on the front page of this data sheet.

In some applications, it may be necessary to operate the MC1496 with a single dc supply voltage instead of dual supplies. Figure 25 shows a balanced modulator designed for operation with a single 12 Vdc supply. Performance of this circuit is similar to that of the dual supply modulator.

#### **AM Modulator**

The circuit shown in Figure 26 may be used as an amplitude modulator with a minor modification.

All that is required to shift from suppressed carrier to AM operation is to adjust the carrier null potentiometer for the proper amount of carrier insertion in the output signal.

However, the suppressed carrier null circuitry as shown in Figure 26 does not have sufficient adjustment range. Therefore, the modulator may be modified for AM operation by changing two resistor values in the null circuit as shown in Figure 27.

#### **Product Detector**

The MC1496 makes an excellent SSB product detector (see Figure 28).

This product detector has a sensitivity of  $3.0 \ \mu V$  and a dynamic range of 90 dB when operating at an intermediate frequency of 9.0 MHz.

The detector is broadband for the entire high frequency range. For operation at very low intermediate frequencies down to 50 kHz the 0.1  $\mu$ F capacitors on Pins 8 and 10 should be increased to 1.0  $\mu$ F. Also, the output filter at Pin 12 can be tailored to a specific intermediate frequency and audio amplifier input impedance.

As in all applications of the MC1496, the emitter resistance between Pins 2 and 3 may be increased or decreased to adjust circuit gain, sensitivity, and dynamic range.

This circuit may also be used as an AM detector by introducing carrier signal at the carrier input and an AM signal at the SSB input.

The carrier signal may be derived from the intermediate frequency signal or generated locally. The carrier signal may

be introduced with or without modulation, provided its level is sufficiently high to saturate the upper quad differential amplifier. If the carrier signal is modulated, a 300 mVrms input level is recommended.

#### **Doubly Balanced Mixer**

The MC1496 may be used as a doubly balanced mixer with either broadband or tuned narrow band input and output networks.

The local oscillator signal is introduced at the carrier input port with a recommended amplitude of 100 mVrms.

Figure 29 shows a mixer with a broadband input and a tuned output.

#### **Frequency Doubler**

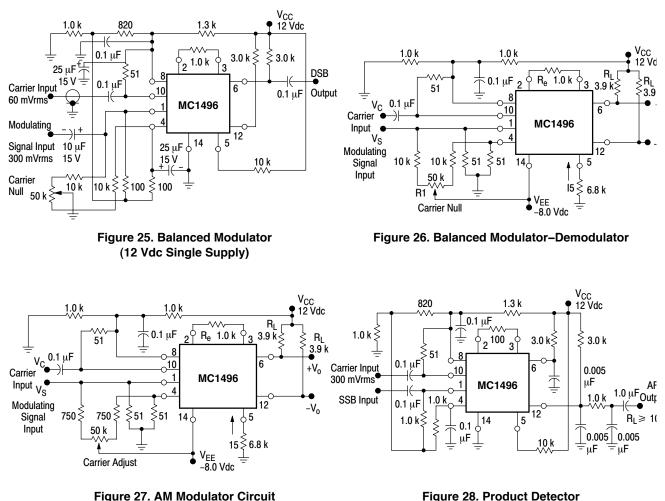
The MC1496 will operate as a frequency doubler by introducing the same frequency at both input ports.

Figures 30 and 31 show a broadband frequency doubler and a tuned output very high frequency (VHF) doubler, respectively.

#### Phase Detection and FM Detection

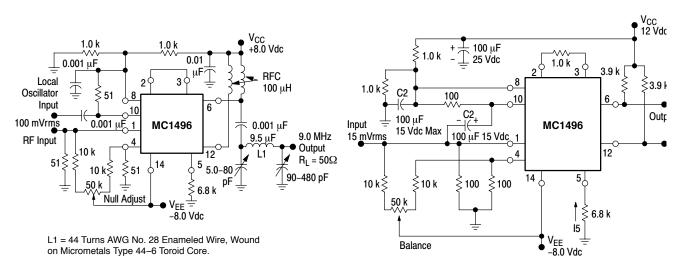
The MC1496 will function as a phase detector. High–level input signals are introduced at both inputs. When both inputs are at the same frequency the MC1496 will deliver an output which is a function of the phase difference between the two input signals.

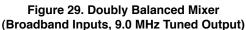
An FM detector may be constructed by using the phase detector principle. A tuned circuit is added at one of the inputs to cause the two input signals to vary in phase as a function of frequency. The MC1496 will then provide an output which is a function of the input signal frequency.



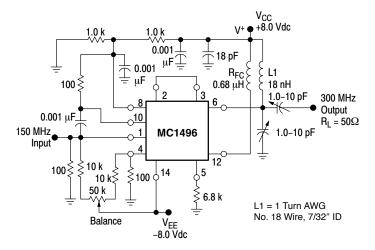
## TYPICAL APPLICATIONS

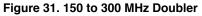
(12 Vdc Single Supply)

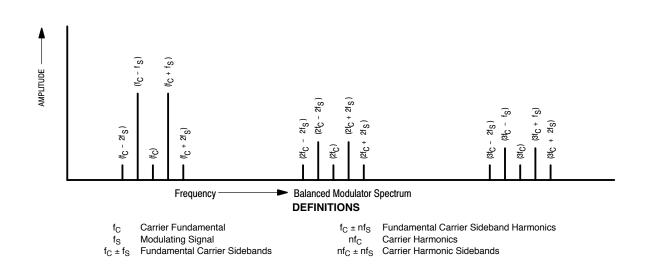










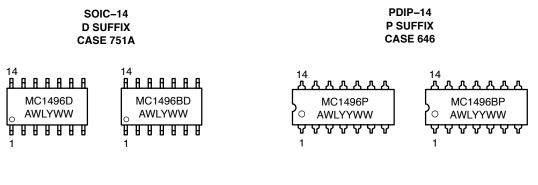


#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MC1496D	SOIC-14	55 Units/Rail
MC1496DR2	SOIC-14	2500 Tape & Reel
MC1496DR2G	SOIC-14 (Pb-Free)	2500 Tape & Reel
MC1496P	PDIP-14	25 Units/Rail
MC1496PG	PDIP-14 (Pb-Free)	25 Units/Rail
MC1496P1	PDIP-14	25 Units/Rail
MC1496BD	SOIC-14	55 Units/Rail
MC1496BDR2	SOIC-14	2500 Tape & Reel
MC1496BP	PDIP-14	25 Units/Rail

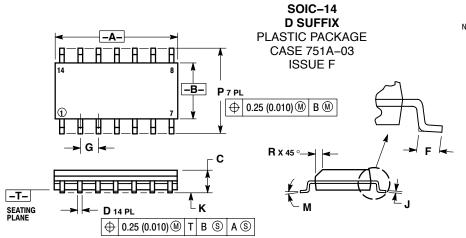
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### MARKING DIAGRAMS



A = Assembly Location WL = Wafer Lot YY, Y = Year WW = Work Week

## PACKAGE DIMENSIONS



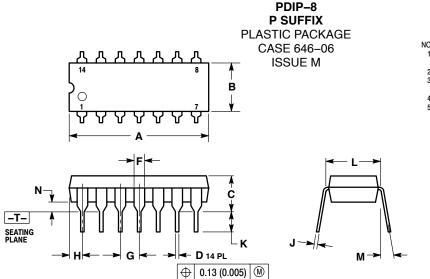
NOT	TES:
1.	DIMENSIONING AND TOLERANCING PER ANSI
	V14 EM 1000

2. 3.

Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4.

MAXIMUM MOLD PHOTHOSION 0.15 (0.006) PER SIDE. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT 5.

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	8.55	8.75	0.337	0.344	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.054	0.068	
D	0.35	0.49	0.014	0.019	
F	0.40	1.25	0.016	0.049	
G	1.27	BSC	0.050 BSC		
ſ	0.19	0.25	0.008	0.009	
Κ	0.10	0.25	0.004	0.009	
М	0 °	7°	0 °	7°	
Ρ	5.80	6.20	0.228	0.244	
R	0.25	0.50	0.010	0.019	



NOTES:

NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL. 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH. 5. ROUNDED CORNERS OPTIONAL.

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.715	0.770	18.16	18.80	
В	0.240	0.260	6.10	6.60	
C	0.145	0.185	3.69	4.69	
D	0.015	0.021	0.38	0.53	
F	0.040	0.070	1.02	1.78	
G	0.100	BSC	2.54 BSC		
Н	0.052	0.095	1.32	2.41	
J	0.008	0.015	0.20	0.38	
K	0.115	0.135	2.92	3.43	
L	0.290	0.310	7.37	7.87	
Μ		10°		10°	
Ν	0.015	0.039	0.38	1.01	

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